

KSA709

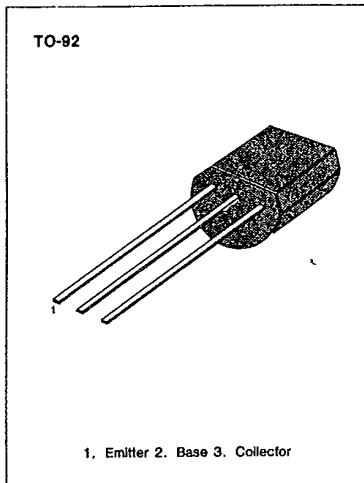
PNP EPITAXIAL SILICON TRANSISTOR

HIGH VOLTAGE AMPLIFIER

- Collector-Base Voltage $V_{CB0} = -160V$
- Collector Dissipation $P_C = 800mW$
- Complement to KSC1009

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	- 160	V
Collector-Emitter Voltage	V_{CEO}	- 150	V
Emitter-Base Voltage	V_{EBO}	- 8	V
Collector Current	I_C	- 700	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CB0}	$I_C = -100\mu A, I_E = 0$	- 160			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	- 150			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	- 8			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -100V, I_E = 0$			- 0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			- 0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -2V, I_C = -50mA^*$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -200mA, I_B = -20mA^*$		- 0.3	- 0.4	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -200mA, I_B = -20mA^*$		- 0.9	- 1.0	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -50mA$		50		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$			10	pF

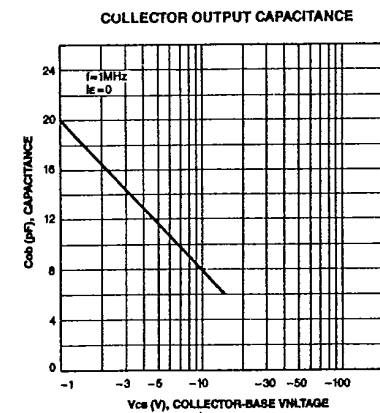
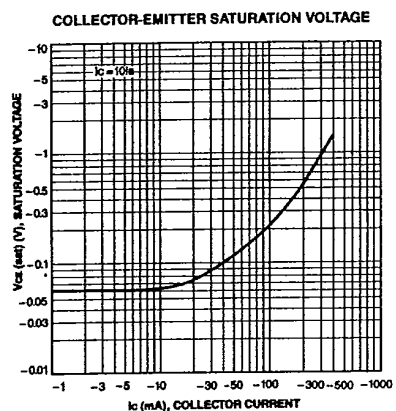
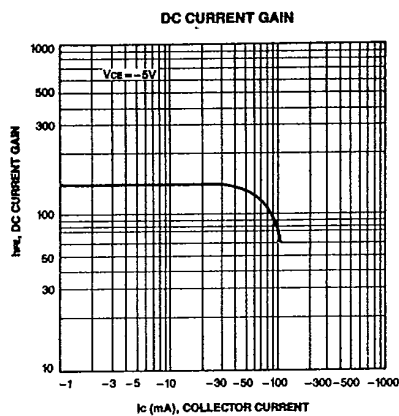
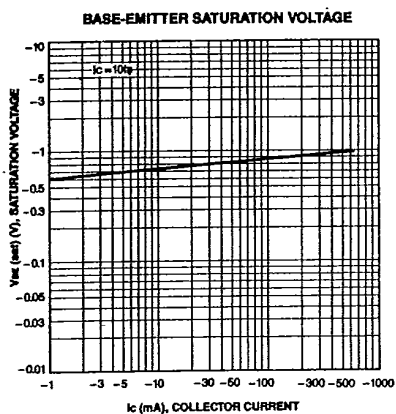
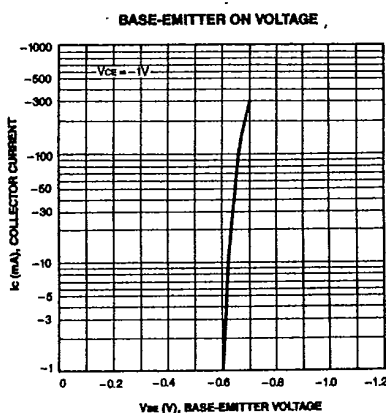
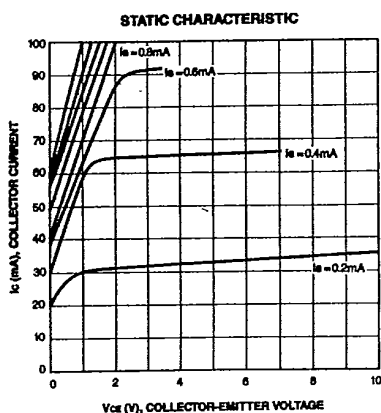
* pulse measured $PW \leq 350\mu s$, duty cycle $\leq 2\%$

h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

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